Test Equipment Solutions Datasheet

Test Equipment Solutions Ltd specialise in the second user sale, rental and distribution of quality test & measurement (T&M) equipment. We stock all major equipment types such as spectrum analyzers, signal generators, oscilloscopes, power meters, logic analysers etc from all the major suppliers such as Agilent, Tektronix, Anritsu and Rohde & Schwarz.

We are focused at the professional end of the marketplace, primarily working with customers for whom high performance, quality and service are key, whilst realising the cost savings that second user equipment offers. As such, we fully test & refurbish equipment in our in-house, traceable Lab. Items are supplied with manuals, accessories and typically a full no-quibble 2 year warranty. Our staff have extensive backgrounds in T&M, totalling over 150 years of combined experience, which enables us to deliver industry-leading service and support. We endeavour to be customer focused in every way right down to the detail, such as offering free delivery on sales, covering the cost of warranty returns BOTH ways (plus supplying a loan unit, if available) and supplying a free business tool with every order.

As well as the headline benefit of cost saving, second user offers shorter lead times, higher reliability and multivendor solutions. Rental, of course, is ideal for shorter term needs and offers fast delivery, flexibility, try-before-you-buy, zero capital expenditure, lower risk and off balance sheet accounting. Both second user and rental improve the key business measure of Return On Capital Employed.

We are based near Heathrow Airport in the UK from where we supply test equipment worldwide. Our facility incorporates Sales, Support, Admin, Logistics and our own in-house Lab.

All products supplied by Test Equipment Solutions include:

- No-quibble parts & labour warranty (we provide transport for UK mainland addresses).
- Free loan equipment during warranty repair, if available.
- Full electrical, mechanical and safety refurbishment in our in-house Lab.
- Certificate of Conformance (calibration available on request).
- Manuals and accessories required for normal operation.
- Free insured delivery to your UK mainland address (sales).
- Support from our team of seasoned Test & Measurement engineers.
- ISO9001 quality assurance.

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Series 2400 SourceMeter® Line

- Five instruments in one (IV Source, IVR Measure)
- Seven models: 20–100W DC, 1000W pulsed, 1100V to 1µV, 10A to 10pA
- Source and sink (4-quadrant) operation
- 0.012% basic measure accuracy with 6½-digit resolution
- 2-, 4-, and 6-wire remote V-source and measure sensing
- 1700 readings/second at 4½ digits via GPIB
- Pass/Fail comparator for fast sorting/binning
- Available high speed sense lead contact check function
- Programmable DIO port for automation/handler/prober control (except Model 2401)
- Standard SCPI GPIB, RS-232 and Keithley Trigger Link interfaces
- Keithley LabTracer 2.0 I-V curve tracing application software (download)

Keithley's SourceMeter family are source measurement unit (SMU) instruments designed specifically for test applications that demand tightly coupled sourcing and measurement. All SourceMeter models provide precision voltage and current sourcing as well as measurement capabilities. Each SourceMeter instrument is both a highly stable DC power source and a true instrument-grade 6½-digit multimeter. The power source characteristics include low noise, precision, and readback. The multimeter capabilities include high repeatability and low noise. The result is a compact, single-channel, DC parametric tester. In operation, these instruments can act as a voltage source, a current source, a voltage meter, a current meter, and an ohmmeter. Manufacturers of components and modules for the communications, semiconductor, computer, automotive, and medical industries will find the SourceMeter instruments invaluable for a wide range of characterization and production test applications.

Advantages of a Tightly Integrated Instrument

By linking source and measurement circuitry in a single unit, these instruments offer a variety of advantages over systems configured with separate source and measurement instruments. For example, they minimize the time required for test station development, setup, and maintenance, while lowering the overall cost of system ownership. They simplify the test process itself by eliminating many of the complex synchronization and connection issues associated with using multiple instruments. And, their compact half-rack size conserves precious "real estate" in the test rack or bench.

Power of Five Instruments in One (IV Source, IVR Measure)

The tightly coupled nature of a SourceMeter instrument provides many advantages over solutions configured from separate instruments, such as a precision power supply and a digital multimeter. For example, it provides faster test times by reducing GPIB traffic and simplifies the remote programming interface. It also protects the device under test from damage due to accidental overloads, thermal runaway, etc. Both the current and voltage source are programmable with readback to help maximize device measurement integrity. If the readback reaches a programmed compliance limit, then the source is clamped at the limit, providing fault protection.

ACCESSORIES AVAILABLE

TEST LEADS AND PROBES

1754	2-Wire Universal 10-Piece Test Lead Kit
5804	Kelvin (4-Wire) Universal 10-Piece Test Lead Kit
5805	Kelvin (4-Wire) Spring-Loaded Probes
5808	Low Cost Single-pin Kelvin Probe Set
5809	Low Cost Kelvin Clip Lead Set
8607	2-Wire, 1000V Banana Cables, 1m (3.3 ft)
CA-18-1	Shielded Dual Banana Cable, 1.2m (4 ft)

SWITCHING HARDWARE

7001	Two-Slot Switch System
7002	Ten-Slot Switch System
7019-C	6-Wire Ohms Switch Card
7053	High-Current Switch Card

CABLES/ADAPTERS

7007-1	Shielded GPIB Cable, 1m (3.3 ft)
7007-2	Shielded GPIB Cable, 2m (6.6 ft)
7009-5	RS-232 Cable
8620	Shorting Plug

COMMUNICATION INTERFACE

KPCI-488LPA	IEEE-488 Interface/Controller for the PCI Bus
KUSB-488B	IEEE-488 USB-to-GPIB Interface Adapter

TRIGGERING AND CONTROL

2499-DIGIO	Digital I/O Expander Assembly (not for Model 2401)
8501-1	Trigger Link Cable, DIN-to-DIN, 1m (3.3 ft)
8501-2	Trigger Link Cable, DIN-to-DIN, 2m (6.6 ft)
8502	Trigger Link to BNC Breakout Box
8503	Trigger Link Cable, DIN-to-Dual BNC, 1m (3.3 ft)
8505	Male to 2-Female Y-DIN Cable for Trigger Link

RACK MOUNT KITS

4288-1	Single Fixed Rack Mount Kit
4288-2	Dual Fixed Rack Mount Kit
4288-4	Dual Fixed Rack Mount Kit
4288-5	Shelf Type Side by Side Rack Mounting Kit
4288-9	Dual Fixed Rack Mounting Kit

SOFTWARE

LabTracer 2.0	Curve Tracing Software (downloadable)

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Series 2400

SourceMeter® Line

Tightly coupled precision sourcing and measurement

SMU INSTRUMENTS

Ordering Information

2400	200V, 1A, 20W SourceMeter Instrument
2400-C	200V, 1A, 20W SourceMeter Instrument with Contact Check
2401	20V, 1A, 20W SourceMeter Instrument
2410	1100V, 1A, 20W SourceMeter Instrument
2410-C	1100V, 1A, 20W SourceMeter Instrument with Contact Check
2420	60V, 3A, 60W SourceMeter Instrument
2420-C	60V, 3A, 60W SourceMeter Instrument with Contact Check
2425	100V, 3A, 100W SourceMeter Instrument
2425-C	100V, 3A, 100W SourceMeter Instrument with Contact Check
2430	100V, 10A, 1000W Pulse Mode SourceMeter Instrument
2430-C	100V, 10A, 1000W Pulse Mode SourceMeter Instrument with Contact Check
2440	40V, 5A, 50W SourceMeter Instrument
2440-C	40V, 5A, 50W SourceMeter Instrument with Contact Check

Accessories Supplied

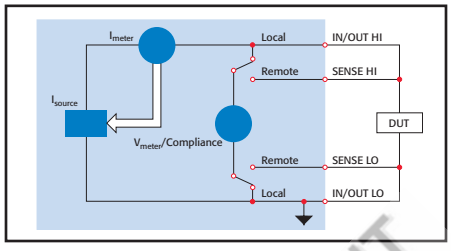
Model 8605 Test Leads

LabVIEW Software Driver (downloadable)

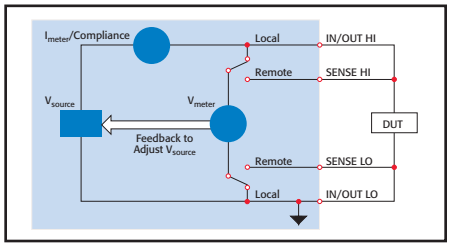
LabTracer Software (downloadable)

I-V Characteristics

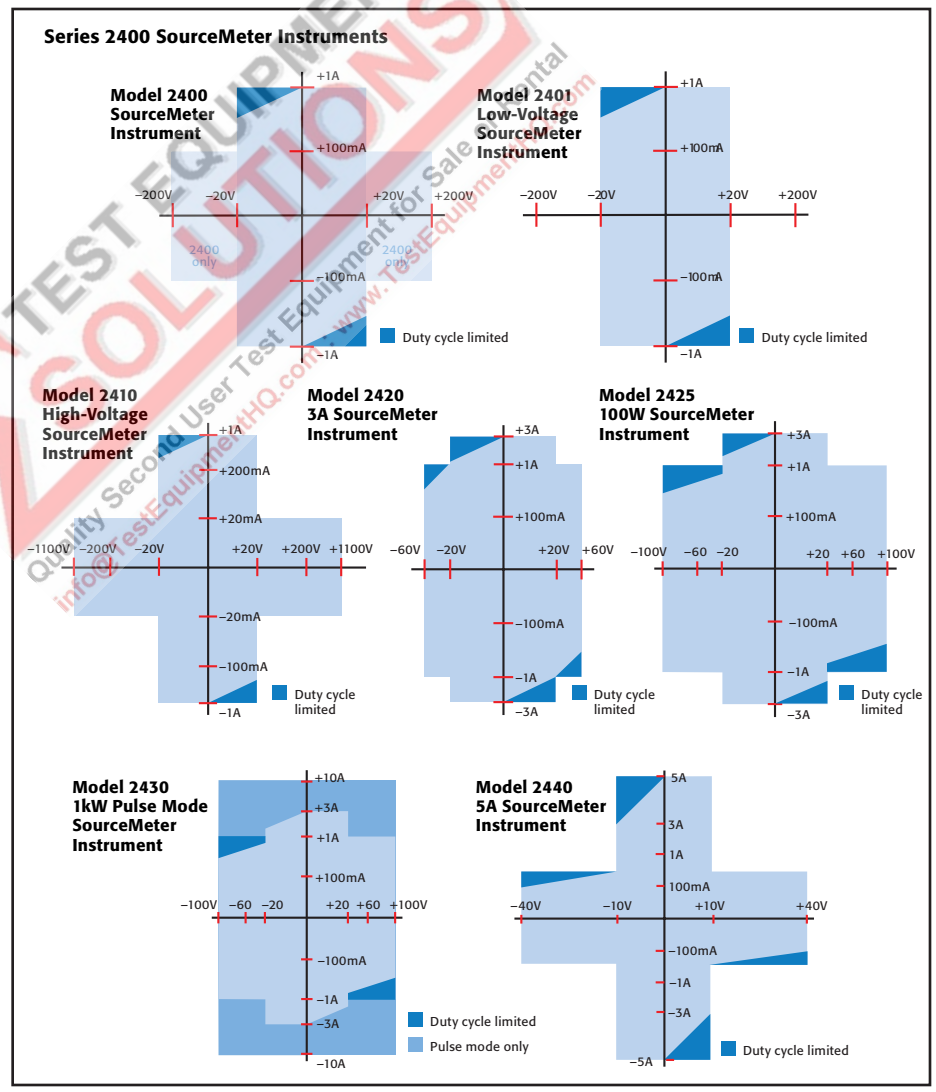
All SourceMeter instruments provide four-quadrant operation. In the first and third quadrants they operate as a source, delivering power to a load. In the second and fourth quadrants they operate as a sink, dissipating power internally. Voltage, current, and resistance can be measured during source or sink operation.



Source I, Measure V, I, or Ω configuration



Source V, Measure I, V, or Ω configuration



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Series 2400 SourceMeter® Line

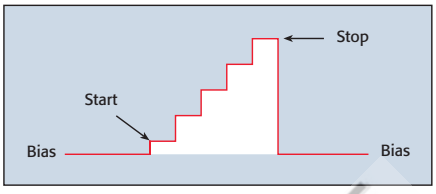
Automation for Speed

A SourceMeter instrument streamlines production testing. It sources voltage or current while making measurements without needing to change connections. It is designed for reliable operation in non-stop production environments. To provide the throughput demanded by production applications, the SourceMeter instrument offers many built-in features that allow it to run complex test sequences without computer control or GPIB communications slowing things down.

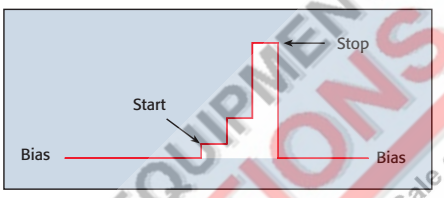
Standard and Custom Sweeps

Sweep solutions greatly accelerate testing with automation hooks. Three basic sweep waveforms are provided that can be programmed for single-event or continuous operation. They are ideal for I/V, I/R, V/I, and V/R characterization.

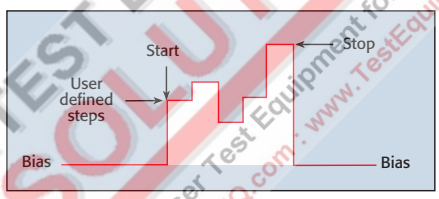
- Linear Staircase Sweep: Moves from the start level to the stop level in equal linear steps
- Logarithmic Staircase Sweep: Done on a log scale with a specified number of steps per decade
- Custom Sweep: Allows construction of special sweeps by specifying the number of measurement points and the source level at each point
- Up to 1700 readings/second at 4½ digits to the GPIB bus
- 5000 readings can be stored in the non-volatile buffer memory



Linear staircase sweep



Logarithmic staircase sweep



Custom sweep

Built-In Test Sequencer (Source Memory List)

The Source Memory list provides faster and easier testing by allowing you to setup and execute up to 100 different tests that run without PC intervention.

- Stores up to 100 instrument configurations, each containing source settings, measurement settings, pass/fail criteria, etc.
- Pass/fail limit test as fast as 500µs per point
- Onboard comparator eliminates the delay caused when sending data to the computer for analysis
- Built-in, user definable math functions to calculate derived parameters

TYPICAL APPLICATIONS

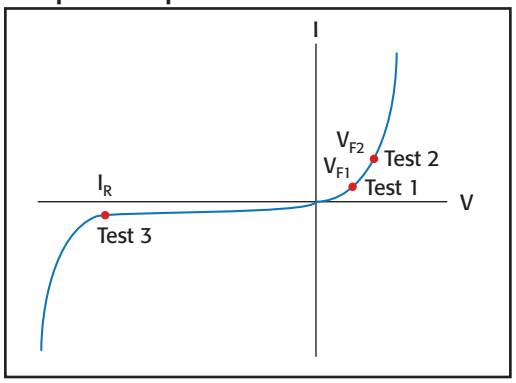
Devices:

- **Discrete semiconductor devices**
- **Passive devices**
- **Transient suppression devices**
- **ICs, RFICs, MMICs**
- **Laser diodes, laser diode modules, LEDs, photodetectors**
- **Circuit protection devices: TVS, MOV, Fuses, etc.**
- **Airbags**
- **Connectors, switches, relays**
- **High brightness LEDs (DC and pulse)**

Tests:

- **Leakage**
- **Low voltage/resistances**
- **LIV**
- **IDDQ**
- **I-V characterization**
- **Isolation and trace resistance**
- **Temperature coefficient**
- **Forward voltage, reverse breakdown, leakage current**
- **DC parametric test**
- **DC power source**
- **HIPOT**
- **Photovoltaic cell efficiency (source and sink)**
- **Dielectric withstanding**

Example Test Sequence



Test	Pass/Fail Test	If Passes Test	If Fails Test
Test 1	Check V_{F1} at 100mA against pass/fail limits	Go to Test 2	1. Bin part to bad bin 2. Transmit data to computer while handler is placing new part 3. Return to Test 1
Test 2	Check V_{F2} at 1A against pass/fail limits	Go to Test 3	
Test 3	Check leakage current at –500V and test against pass/fail limits	1. Bin part to good bin 2. Transmit readings to computer while handler is placing new part 3. Return to Test 1	

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Digital I/O Interface

The digital I/O interface can link the SourceMeter instrument to many popular component handlers, including Aetrium, Aeco, and Robotronics. Other capabilities of the interface include:

- Tight systems integration for applications such as binning and sorting
- Built-in component handler interface
- Start of test and end of test signals
- 5V, 300mA power supply
- Optional expander accessory (Model 2499-DIGIO) adds 16 digital I/O lines

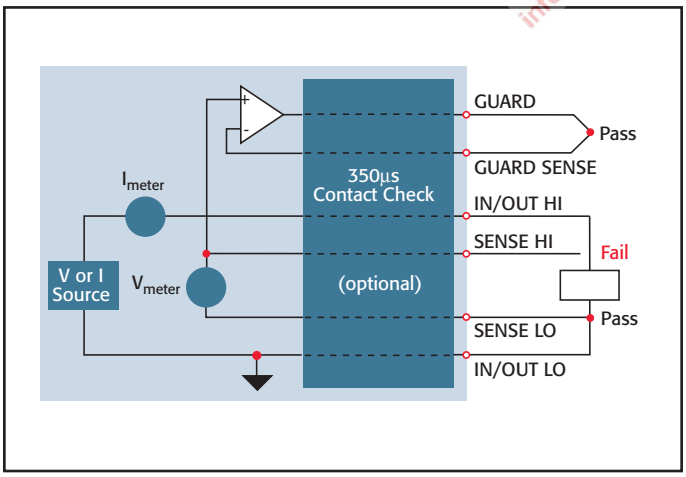
Trigger Link Interface

All SourceMeter instruments include Keithley's unique Trigger Link interface which provides high-speed, seamless communications with many of Keithley's other instruments. For example, use the Trigger Link interface to connect a SourceMeter instrument with a Series 7000 Switching System for a complete multi-point test solution. With Trigger Link, the 7000 Series Switching Systems can be controlled by a SourceMeter instrument during a high-speed test sequence independent of a computer and GPIB.

Optional Contact Check Function

The Contact Check function makes it simple to verify good connections quickly and easily before an automated test sequence begins. This eliminates measurement errors and false product failures associated with contact fatigue, breakage, contamination, loose or broken connection, relay failures, etc. Some capabilities of this function are:

- 350μs verification and notification process time
- The output of the SourceMeter instrument is automatically shut off after a fault and is not re-activated until good contact is verified, protecting the device under test from damage and the operator from potential safety hazards
- 3 pass/fail threshold values: 2Ω, 15Ω, and 50Ω
- No energy passes through the device under test during the operation
- Enabled either from the front panel or remotely over the GPIB
- 3 fault notification methods

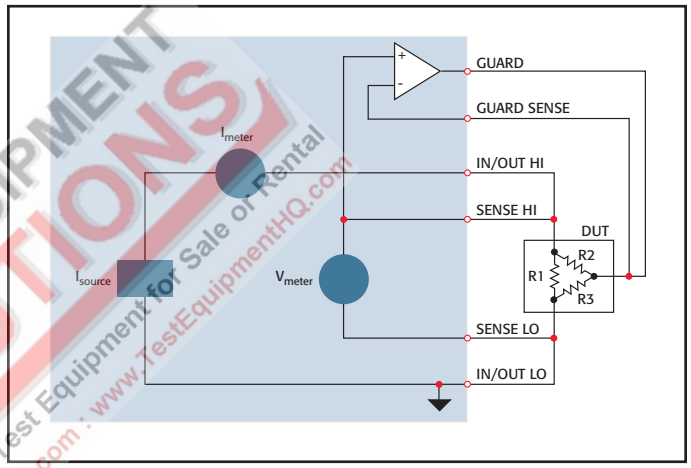


Contact check option for 4-wire or 6-wire applications

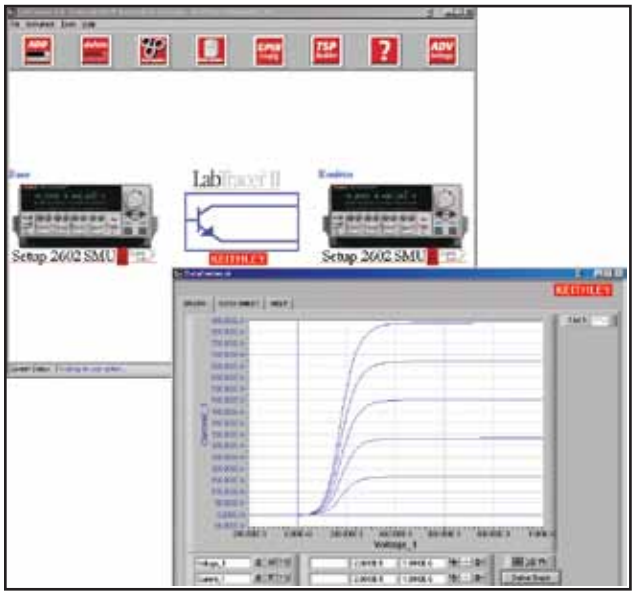
Unique 6-Wire Ohms Technique

SourceMeter instruments can make standard 4-wire, split Kelvin, and 6-wire, guarded ohms measurements and can be configured for either the constant current or constant voltage method. The 6-wire ohms technique:

- Uses guard and guard sense leads in addition to the 4-wire sense and source leads
- Locks out parallel current paths when measuring resistor networks or hybrid circuits to isolate the component under test
- Allows users to configure and plot data easily from Series 2400 SourceMeter instruments, making characterization of two, three, and four terminal devices a snap



6-Wire Ohms Circuit. All test current flows through R1 because the high current guard drives the voltage across R2 to 0V.



Free LabTracer 2.0 device characterization software (downloadable)

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Voltage Accuracy (Local or Remote Sense)

Model	Range	Programming Resolution	Source[1] Accuracy (1 Year) 23°C ±5°C ±(% rdg. + volts)	Default Measurement Resolution	Measurement[2, 3, 4] Accuracy (1 Year) 23°C ±5°C ±(% rdg. + volts)	Output Slew Rate (±30%)	Source/Sink Limit
2400, 2400-C, 2401	200.000 mV	5 µV	0.02% + 600 µV	1 µV	0.012% + 300 µV		±21 V @ ±1.05 A ±210 V @ ±105 mA*
	2.00000 V	50 µV	0.02% + 600 µV	10 µV	0.012% + 300 µV		
	20.0000 V	500 µV	0.02% + 2.4 mV	100 µV	0.015% + 1.5 mV	0.08 V/µs	
	200.000 V*	5 mV	0.02% + 24 mV	1 mV	0.015% + 10 mV	0.5 V/µs	
2410, 2410-C	200.000 mV	5 µV	0.02% + 600 µV	1 µV	0.012% + 300 µV		±21 V @ ±1.05 A ±1100 V @ ±21 mA
	2.00000 V	50 µV	0.02% + 600 µV	10 µV	0.012% + 300 µV		
	20.0000 V	500 µV	0.02% + 2.4 mV	100 µV	0.015% + 1 mV	0.15 V/µs	
	1000.00 V	50 mV	0.02% + 100 mV	10 mV	0.015% + 50 mV	0.5 V/µs	
2420, 2420-C	200.000 mV	5 µV	0.02% + 600 µV	1 µV	0.012% + 300 µV		±21 V @ ±3.15 A ±63 V @ ±1.05 A
	2.00000 V	50 µV	0.02% + 600 µV	10 µV	0.012% + 300 µV		
	20.0000 V	500 µV	0.02% + 2.4 mV	100 µV	0.015% + 1 mV	0.08 V/µs	
	60.0000 V	1.5 mV	0.02% + 7.2 mV	1 mV	0.015% + 3 mV	0.14 V/µs	
2425, 2425-C	200.000 mV	5 µV	0.02% + 600 µV	1 µV	0.012% + 300 µV		±21 V @ ±3.15 A ±105 V @ ±1.05 A
	2.00000 V	50 µV	0.02% + 600 µV	10 µV	0.012% + 300 µV		
	20.0000 V	500 µV	0.02% + 2.4 mV	100 µV	0.015% + 1 mV	0.08 V/µs	
	100.0000 V	2.5 mV	0.02% + 12 mV	1 mV	0.015% + 5 mV	0.25 V/µs	
2430, 2430-C	200.000 mV	5 µV	0.02% + 600 µV	1 µV	0.012% + 300 µV		±105 V @ ±1.05 A ±105 V @ ±10.5 A (pulse mode only)
	2.00000 V	50 µV	0.02% + 600 µV	10 µV	0.012% + 300 µV		
	20.0000 V	500 µV	0.02% + 2.4 mV	100 µV	0.015% + 1 mV	0.08 V/µs	
	100.0000 V	2.5 mV	0.02% + 12 mV	1 mV	0.015% + 5 mV	0.25 V/µs	
2440, 2440-C	200.000 mV	5 µV	0.02% + 600 µV	1 µV	0.012% + 300 µV		±10.5 V @ ±5.25 A ±42 V @ ±1.05 A
	2.00000 V	50 µV	0.02% + 600 µV	10 µV	0.012% + 300 µV		
	10.0000 V	500 µV	0.02% + 1.2 mV	100 µV	0.015% + 750 µV	0.08 V/µs	
	40.0000 V	5 mV	0.02% + 4.8 mV	1 mV	0.015% + 3 mV	0.25 V/µs	

***Not available on Model 2401.**

TEMPERATURE COEFFICIENT (0°–18°C and 28°–50°C): ±(0.15 × accuracy specification)/°C.
VOLTAGE REGULATION: Line: 0.01% of range. **Load:** 0.01% of range + 100µV.
OVER VOLTAGE PROTECTION: User selectable values, 5% tolerance. Factory default = none.
CURRENT LIMIT: Bipolar current limit (compliance) set with single value. Min. 0.1% of range.
OVERSHOOT: <0.1% typical (full scale step, resistive load, 10mA range).

ADDITIONAL SOURCE SPECIFICATIONS (All Models)

TRANSIENT RESPONSE TIME: 30µs minimum for the output to recover to its spec. following a step change in load.
COMMAND PROCESSING TIME: Maximum time required for the output to begin to change following the receipt of :SOURce:VOLTage|CURRent <nrf> command. **Autorange On:** 10ms. **Autorange Off:** 7ms.
OUTPUT SETTLING TIME: Time required to reach 0.1% of final value after command is processed. 100µs typical. Resistive load. 10µA to 100mA range.
DC FLOATING VOLTAGE: Output can be floated up to ±250VDC (Model 2440 ±40VDC) from chassis ground.
REMOTE SENSE: Up to 1V drop per load lead.
COMPLIANCE ACCURACY: Add 0.3% of range and ±0.02% of reading to base specification.
OVER TEMPERATURE PROTECTION: Internally sensed temperature overload puts unit in standby mode.
RANGE CHANGE OVERSHOOT: Overshoot into a fully resistive 100kΩ load, 10Hz to 1MHz BW, adjacent ranges: 100mV typical, except 20V/200V (20V/60V on Model 2420), 20V/100V on Model 2425 and 2430, range boundary, and Model 2440.
MINIMUM COMPLIANCE VALUE: 0.1% of range.

ADDITIONAL PULSE MODE SOURCE SPECIFICATIONS (2430 and 2430-C only)

MAXIMUM DUTY CYCLE: 8%, hardware limited, 10A range only. All other ranges 100%.
MAXIMUM PULSE WIDTH: 5ms from 90% rising to 90% falling edge, 2.5ms 10A range.
MINIMUM PULSE WIDTH: 150µs.
MINIMUM PULSE RESOLUTION: 50µs typical, 70µs max., limited by system jitter.
SOURCE ACCURACY: Determined by settling time and source range specifications.
OUTPUT SETTLING TIME 0.1%:
800µs typ., source I = 10A into 10Ω, limited by voltage slew rate.
500µs typ., source I = 10A into 1Ω, limited by voltage slew rate.
OUTPUT SLEW RATE:
Voltage (10Ω load): 0.25V/µs ±30% on 100V range. 0.08V/µs ±30% on 20V range, 10A range.
Current (0Ω load): 0.25A/µs ±30% on 100V range. 0.08A/µs ±30% on 20V range, 10A range.

NOTES

1. **2400, 2401, 2410 Only:** Specifications valid for continuous output currents below 105mA. For operation above 105mA continuous for >1 minute, derate accuracy 10%/35mA above 105mA.
2. Speed = Normal (1 PLC). For 0.1 PLC, add 0.005% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.05%. For 0.01 PLC, add 0.05% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.5%.
3. Accuracies apply to 2- or 4-wire mode when properly zeroed.
4. In pulse mode, limited to 0.1 PLC measurement.

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Series 2400 SourceMeter® Line

Current Accuracy (Local or Remote Sense)

Model	Range	Programming Resolution	Source[1, 3] Accuracy (1 Year)[3] 23°C ±5°C ±(% rdg. + amps)	Default Measurement Resolution	Measurement[5, 6, 7] Accuracy (1 Year) 23°C ±5°C ±(% rdg. + amps)	Source/Sink Limit
2400, 2400-C, 2401	1.00000 µA	50 pA	0.035% + 600 pA	10 pA	0.029% + 300 pA	±1.05A @ ±21 V ±105 mA @ ±210 V[8]
	10.0000 µA	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	
	100.000 µA	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	
	10.0000 mA	500 nA	0.045% + 2 µA	100 nA	0.035% + 600 nA	
	100.000 mA	5 µA	0.066% + 20 µA	1 µA	0.055% + 6 µA	
	1.00000 A[2]	50 µA	0.27 % + 900 µA	10 µA	0.22 % + 570 µA	
2410, 2410-C	1.00000 µA	50 pA	0.035% + 600 pA	10 pA	0.029% + 300 pA	±1.05A @ ±21 V ±21 mA @ ±1100 V
	10.0000 µA	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	
	100.000 µA	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	
	20.0000 mA	500 nA	0.045% + 4 µA	100 nA	0.035% + 1.2 µA	
	100.000 mA	5 µA	0.066% + 20 µA	1 µA	0.055% + 6 µA	
	1.00000 A[2]	50 µA	0.27 % + 900 µA	10 µA	0.22 % + 570 µA	
2420, 2420-C	10.0000 µA	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	±3.15A @ ±21 V ±1.05 A @ ±63 V
	100.000 µA	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	
	10.0000 mA	500 nA	0.045% + 2 µA	100 nA	0.035% + 600 nA	
	100.000 mA	5 µA	0.066% + 20 µA	1 µA	0.055% + 6 µA	
	1.00000 A[2]	50 µA	0.067% + 900 µA	10 µA	0.066% + 570 µA	
	3.00000 A[2]	50 µA	0.059% + 2.7 mA	10 µA	0.052% + 1.71 mA	
2425, 2425-C	10.0000 µA	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	±3.15A @ ±21 V ±1.05 A @ ±105 V
	100.000 µA	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	
	10.0000 mA	500 nA	0.045% + 2 µA	100 nA	0.035% + 600 nA	
	100.000 mA	5 µA	0.066% + 20 µA	1 µA	0.055% + 6 µA	
	1.00000 A[2]	50 µA	0.067% + 900 µA	10 µA	0.060% + 570 µA	
	3.00000 A[2]	50 µA	0.059% + 2.8 mA	10 µA	0.052% + 1.71 mA	
2430, 2430-C	10.0000 µA	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	±1.05A @ ±105 V ±10.5 A @ ±105 V (pulse mode only)
	100.000 µA	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	
	10.0000 mA	500 nA	0.045% + 2 µA	100 nA	0.035% + 600 nA	
	100.000 mA	5 µA	0.066% + 20 µA	1 µA	0.055% + 6 µA	
	1.00000 A	50 µA	0.067% + 900 µA	10 µA	0.060% + 570 µA	
	3.00000 A[2]	500 µA	0.059% + 2.8 mA	10 µA	0.052% + 1.71 mA	
	10.00000 A[4]	500 µA	0.089% + 5.9 mA	10 µA	0.082% + 1.71 mA	
2440, 2440-C	10.0000 µA	500 pA	0.033% + 2 nA	100 pA	0.027% + 700 pA	±5.25A @ ±10.5 V ±1.05 A @ ±42 V
	100.000 µA	5 nA	0.031% + 20 nA	1 nA	0.025% + 6 nA	
	1.00000 mA	50 nA	0.034% + 200 nA	10 nA	0.027% + 60 nA	
	10.0000 mA	500 nA	0.045% + 2 µA	100 nA	0.035% + 600 nA	
	100.000 mA	5 µA	0.066% + 20 µA	1 µA	0.055% + 6 µA	
	1.00000 A	50 µA	0.067% + 900 µA	10 µA	0.060% + 570 µA	
	5.00000 A	50 µA	0.10 % + 5.4 mA	10 µA	0.10 % + 3.42 mA	

TEMPERATURE COEFFICIENT (0°–18°C and 28°–50°C): ±(0.15 × accuracy specification)/°C.

CURRENT REGULATION: Line: 0.01% of range. **Load:** 0.01% of range (except Model 2440 5A range 0.05%) + 100pA.

VOLTAGE LIMIT: Bipolar voltage limit (compliance) set with single value. Min. 0.1% of range.

OVERSHOOT: <0.1% typical (1mA step, RL = 10kΩ, 20V range for Model 2400, 2401, 2410, 2420, 2425, 2430), (10V range for Model 2440).

CONTACT CHECK SPECIFICATIONS (requires -C version)

(Not available for Model 2401)

SPEED: 350µs for verification and notification.

CONTACT CHECK:	2 Ω	15 Ω	50 Ω
No contact check failure	<1.00 Ω	<13.5 Ω	<47.5 Ω
Always contact check failure	>3.00 Ω	>16.5 Ω	>52.5 Ω

NOTES

1. **2400, 2401, 2410 Only:** Specifications valid for continuous output currents below 105mA. For operation above 105mA continuous for >1 minute, derate accuracy 10%/35mA above 105mA.
2. Full operation (1A) regardless of load to 30°C (50°C for Model 2420 and 2440). Above 30°C (50°C for Model 2420 and 2440) ambient, derate 35mA/°C and prorate 35mA/Ω load. 4-wire mode. For current sink operation on 1A, 3A, or 5A ranges, maximum continuous power is limited to approximately 1/2 rated power or less, depending on current, up to 30°C ambient. See power equations in the User's Manual to calculate allowable duty cycle for specific conditions.
3. For sink mode, 1µA to 100mA range, accuracy is:
   Model 2400, 2401: ±(0.15% + offset*4). **Models 2410, 2420, 2425, 2430, 2440:** ±(0.5% + offset*3).
   For 1A range, accuracy is:
   Model 2400, 2401: ±(1.5% + offset*8). **Models 2410, 2420, 2425, 2430, 2440:** ±(1.5% + offset*3).
4. 10A range only in pulse mode. Limited to 2.5ms pulse width maximum. 10% duty cycle maximum.
5. Speed = Normal (1 PLC). For 0.1 PLC, add 0.005% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.05%. For 0.01 PLC, add 0.05% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.5%.
6. Accuracies apply to 2- or 4-wire mode when properly zeroed.
7. In pulse mode, limited to 0.1 PLC measurement.
8. Model 2400 and 2400-C only.

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Resistance Measurement Accuracy (Local or Remote Sense)[1, 2, 5]

Range	Default Resolution	Default Test Current 2400, 2401, 2410	Default Test Current 2420, 2425, 2430, 2440	Normal Accuracy (23°C ±5°C) 1 Year, ±(% rdg. + ohms) 2400, 2401	2410	2420, 2425, 2430, 2440	Enhanced Accuracy (23°C ±5°C)[4] 1 Year, ±(% rdg. + ohms) 2400, 2401
<0.20000 Ω[3]	–	–	–	Source I_{ACC} + Meas. V_{ACC}	Source I_{ACC} + Meas. V_{ACC}	Source I_{ACC} + Meas. V_{ACC}	Source I_{ACC} + Meas. V_{ACC}
2.00000 Ω[3]	10 μΩ	–	1 A	Source I_{ACC} + Meas V_{ACC}	Source I_{ACC} + Meas. V_{ACC}	0.17% + 0.0003Ω	Source I_{ACC} + Meas. V_{ACC}
20.0000 Ω	100 μΩ	100 mA	100 mA	0.10% + 0.003 Ω	0.11% + 0.006 Ω	0.10% + 0.003 Ω	0.07% + 0.001 Ω
200.000 Ω	1 mΩ	10 mA	10 mA	0.08% + 0.03 Ω	0.09% + 0.1 Ω	0.08% + 0.03 Ω	0.05% + 0.01 Ω
2.00000 kΩ	10 mΩ	1 mA	1 mA	0.07% + 0.3 Ω	0.08% + 0.6 Ω	0.07% + 0.3 Ω	0.05% + 0.1 Ω
20.0000 kΩ	100 mΩ	100 μA	100 μA	0.06% + 3 Ω	0.07% + 6 Ω	0.06% + 3 Ω	0.04% + 1 Ω
200.000 kΩ	1 Ω	10 μA	10 μA	0.07% + 30 Ω	0.07% + 60 Ω	0.07% + 30 Ω	0.05% + 10 Ω
2.00000 MΩ[6]	10 Ω	1 μA	1 μA	0.11% + 300 Ω	0.12% + 600 Ω	0.11% + 300 Ω	0.05% + 100 Ω
20.0000 MΩ[7]	100 Ω	1 μA	1 μA	0.11% + 1 kΩ	0.12% + 2.4 kΩ	0.11% + 1 kΩ	0.05% + 500 Ω
200.000 MΩ[3]	1 kΩ	100 nA	–	0.66% + 10 kΩ	0.66% + 24 kΩ	Source I_{ACC} + Meas. V_{ACC}	0.35% + 5 kΩ
>200.000 MΩ[3]	–	–	–	Source I_{ACC} + Meas. V_{ACC}	Source I_{ACC} + Meas. V_{ACC}	Source I_{ACC} + Meas. V_{ACC}	Source I_{ACC} + Meas. V_{ACC}

TEMPERATURE COEFFICIENT (0°–18°C and 28°–50°C): ±(0.15 × accuracy specification)/°C.

SOURCE I MODE, MANUAL OHMS: Total uncertainty = I source accuracy + V measure accuracy (4-wire remote sense).

SOURCE V MODE, MANUAL OHMS: Total uncertainty = V source accuracy + I measure accuracy (4-wire remote sense).

6-WIRE OHMS MODE: Available using active ohms guard and guard sense. Max. Guard Output Current: 50mA (except 1A range). Accuracy is load dependent. Refer to White Paper no. 2033 for calculation formula.

GUARD OUTPUT IMPEDANCE: <0.1Ω in ohms mode.

NOTES

1. Speed = Normal (1 PLC). For 0.1 PLC, add 0.005% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.05%. For 0.01 PLC, add 0.05% of range to offset specifications, except 200mV, 1A, 10A ranges, add 0.5%.
2. Accuracies apply to 2- or 4-wire mode when properly zeroed.
3. Manual ohms only – except 2420, 2425, 2430, 2440 for 2Ω range and 2400, 2401 or 2410 for 200MΩ range.
4. Source readback enabled, offset compensation ON. Also available on 2410, 2420, 2425, 2430, and 2440 with similar accuracy enhancement.
5. In pulse mode, limited to 0.1 PLC measurement.
6. Except 2440; default test current is 5μA.
7. Except 2440; default test current is 0.5μA.

SERVICES AVAILABLE

2400-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2400-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2401-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2410-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2410-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2420-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2420-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2425-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2425-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2430-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2430-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2440-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
2440-C-3Y-EW	1-year factory warranty extended to 3 years from date of shipment
C/2400-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2400, 2400-C, 2400-LV*
C/2401-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Model 2401*
C/2410-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2410, 2410-C*
C/2420-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2420, 2420-C*
C/2425-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2425, 2425-C*
C/2430-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2430, 2430-C*
C/2440-3Y-ISO	3 (ISO-17025 accredited) calibrations within 3 years of purchase for Models 2440, 2440-C*
TRN-2400-1-C	Course: Unleashing the Power of Your SourceMeter Instrument

*Not available in all countries

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System Speeds

MEASUREMENT[1]

MAXIMUM RANGE CHANGE RATE: 75/second.

MAXIMUM MEASURE AUTORANGE TIME: 40ms (fixed source).[2]

Sweep Operation[3] Reading Rates (rdg./second) for 60Hz (50Hz):

Speed	NPLC/Trigger Origin	Measure To Mem.	Measure To GPIB	Source-Measure To Mem.	Source-Measure To GPIB	Source-Measure Pass/Fail Test[4, 5] To Mem.	Source-Measure Pass/Fail Test[4, 5] To GPIB	Source-Memory[4] To Mem.	Source-Memory[4] To GPIB
Fast	0.01 / internal	2081 (2030)	1754	1551 (1515)	1369	902 (900)	981	165 (162)	165
IEEE-488.1 Mode	0.01 / external	1239 (1200)	1254	1018 (990)	1035	830 (830)	886	163 (160)	163
Fast	0.01 / internal	2081 (2030)	1198 (1210)	1551 (1515)	1000 (900)	902 (900)	809 (840)	165 (162)	164 (162)
IEEE-488.2 Mode	0.01 / external	1239 (1200)	1079 (1050)	1018 (990)	916 (835)	830 (830)	756 (780)	163 (160)	162 (160)
Medium	0.10 / internal	510 (433)	509 (433)	470 (405)	470 (410)	389 (343)	388 (343)	133 (126)	132 (126)
IEEE-488.2 Mode	0.10 / external	438 (380)	438 (380)	409 (360)	409 (365)	374 (333)	374 (333)	131 (125)	131 (125)
Normal	1.00 / internal	59 (49)	59 (49)	58 (48)	58 (48)	56 (47)	56 (47)	44 (38)	44 (38)
IEEE-488.2 Mode	1.00 / external	57 (48)	57 (48)	57 (48)	57 (47)	56 (47)	56 (47)	44 (38)	44 (38)

Single Reading Operation Reading Rates (rdg./second) for 60Hz (50Hz):

Speed	NPLC/Trigger Origin	Measure To GPIB	Source-Measure[5] To GPIB	Source-Measure Pass/Fail Test[4,5] To GPIB
Fast (488.1)	0.01 / internal	537	140	135
Fast (488.2)	0.01 / internal	256 (256)	79 (83)	79 (83)
Medium (488.2)	0.10 / internal	167 (166)	72 (70)	69 (70)
Normal (488.2)	1.00 / internal	49 (42)	34 (31)	35 (30)

Component for 60Hz (50Hz):[4, 6]

Speed	NPLC/Trigger Origin	Measure To GPIB	Source Pass/Fail Test	Source-Measure Pass/Fail Test[5, 7] To GPIB
Fast	0.01 / external	1.04 ms (1.08 ms)	0.5 ms (0.5 ms)	4.82 ms (5.3 ms)
Medium	0.10 / external	2.55 ms (2.9 ms)	0.5 ms (0.5 ms)	6.27 ms (7.1 ms)
Normal	1.00 / external	17.53 ms (20.9 ms)	0.5 ms (0.5 ms)	21.31 ms (25.0 ms)

NOTES

[1] Reading rates applicable for voltage or current measurements. Auto zero off, autorange off, filter off, display off, trigger delay = 0, and binary reading format.

[2] Purely resistive lead. 1μA and 10μA ranges <65ms.

[3] 1000 point sweep was characterized with the source on a fixed range.

[4] Pass/Fail test performed using one high limit and one low math limit.

[5] Includes time to re-program source to a new level before making measurement.

[6] Time from falling edge of START OF TEST signal to falling edge of END OF TEST signal.

[7] Command processing time of :SOURce:VOLTage|CURRent:TRIGgered <nrf> command not included.

GENERAL

Noise Rejection:

	NPLC	NMRR	CMRR
Fast	0.01	—	80 dB
Medium	0.1	—	80 dB
Slow	1	60 dB	100 dB[1]

[1] Except lowest 2 current ranges = 90dB.

LOAD IMPEDANCE: Stable into 20,000pF typical.

COMMON MODE VOLTAGE: 250V DC (40V DC for Model 2440).

COMMON MODE ISOLATION: >10^9Ω, <1000pF.

OVERRANGE: 105% of range, source and measure.

MAX. VOLTAGE DROP BETWEEN INPUT/OUTPUT AND SENSE TERMINALS: 5V.

MAX. SENSE LEAD RESISTANCE: 1MΩ for rated accuracy.

SENSE INPUT IMPEDANCE: >10^{10}Ω.

GUARD OFFSET VOLTAGE: <150μV, typical (300μV for Models 2430, 2440).

SOURCE OUTPUT MODES:
Pulse (Model 2430 only)
Fixed DC level
Memory List (mixed function)
Stair (linear and log)

MEMORY BUFFER: 5,000 readings @ 5 digits (two 2,500 point buffers). Includes selected measured value(s) and time stamp. Lithium battery backup (3 yr+ battery life).

SOURCE MEMORY LIST: 100 points max.

PROGRAMMABILITY: IEEE-488 (SCPI-1995.0), RS-232, 5 user-definable power-up states plus factory default and *RST.

DIGITAL INTERFACE:
Interlock: Active low input.
Handler Interface: Start of test, end of test, 3 category bits. +5V@ 300mA supply.
Digital I/O: 1 trigger input, 4 TTL/Relay Drive outputs (33V @ 500mA, diode clamped).

POWER SUPPLY: 100V to 240V rms, 50–60Hz (automatically detected at power up). **Model 2400, 2401:** 190VA. **Model 2410:** 210VA. **Model 2420:** 220VA. **Model 2425, 2430:** 250VA. **Model 2440:** 240VA.

COOLING: Model 2401: Convection. **Model 2410, 2420, 2425, 2430, 2440:** Forced air, variable speed.

EMC: Conforms to European Union Directive 89/336/EEC, EN 61326-1.

SAFETY: UL listed to UL 61010B-1:2003: Conforms to European Union Low Voltage Directive.

VIBRATION: MIL-PRF-28800F Class 3 Random.

WARM-UP: 1 hour to rated accuracies.

DIMENSIONS: 89mm high × 213mm wide × 370mm deep (3½ in × 8⅜ in × 14⅝ in). **Bench Configuration (with handle and feet):**104mm high × 238mm wide × 370mm deep (4⅛ in × 9⅜ in × 14⅝ in).

WEIGHT: 3.21kg (7.08 lbs) (Model 2425, 2430, 2440: 4.1kg, 9.0 lbs).

ENVIRONMENT: Operating: 0°–50°C, 70% R.H. up to 35°C. Derate 3% R.H./°C, 35°–50°C. **Storage:** –25°C to 65°C.

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